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PTO/SB/08A (08-00)

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| <b>Substitute for form 1449A/PTO</b><br><br><b>INFORMATION DISCLOSURE<br/>STATEMENT BY APPLICANT</b><br><br>(use as many sheets as necessary) |        | <b>Complete if Known</b> |                  |
|   |        | Application Number       | 09/844,673       |
|   |        | Filing Date              | April 30, 2001   |
|   |        | First Named Inventor     | THEKKATH         |
|   |        | Group Art Unit           | 2192             |
|   |        | Examiner Name            | Rutten, James D. |
| Sheet   | 1 of 1 | Attorney Docket Number   | MTEC-006/00US    |

| OTHER - NON PATENT LITERATURE DOCUMENTS |                       |   |                |
|---|-----------------------|---|----------------|
| Examiner Initials*                      | Cite No. <sup>1</sup> | Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published. | T <sup>2</sup> |
| JDR                                     | D1.                   | F. Chow et al., "Engineering a RISC Compiler System," <i>IEEE COMP-CON</i> , March 1986, pp. 132-137.   |                |
| JDR                                     | D2.                   | M.D. Smith, "Tracing with Pixie," <i>Technical Report CSL-TR-91-497</i> , Stanford University, Computer Systems Laboratory, November 1991, pp. 1-29.  |                |
| JDR                                     | D3.                   | ATOM Reference Manual, <i>Digital Equipment Corporation</i> , Massachusetts, December 1993, pp. 1-32.   |                |
| JDR                                     | D4.                   | A. Srivastaba et al., "ATOM: A System for Building Customized Program Analysis Tools," <i>WRL, Research Report 94/2</i> , Digital Equipment Corporation, Massachusetts, March 1994, pp. 1-23.   |                |
| JDR                                     | D5.                   | ATOM User Manual, <i>Digital Equipment Corporation</i> , March 1994, pp. 1-28.  |                |
| JDR                                     | D6.                   | B. Cmelik et al., "Shade: A Fast Instruction-Set Simulator for Execution Profiling," <i>Proceedings of the 1994 ACM SIGMETRICS Conference</i> , SIGMETRICS, California, May 1994, pp. 128-137.  |                |
| JDR                                     | D7.                   | MIPS Technologies; "MIPS64 5K™ Processor Core Integrator's Guide;" [Document No. MD00056]; <i>MIPS Technologies, Inc.</i> ; Rev. 1.2; August 11, 2000; pp. I-II, 1-82.  |                |
| JDR                                     | D8.                   | MIPS Technologies; "MIPS64™ 5K™ Processor Core Family Integrator's Guide;" [Document No. MD00106]; ©1999-2001 <i>MIPS Technologies, Inc.</i> ; Rev. 02.00; January 15, 2001; pp. I-VIII, 1-75.  |                |
| JDR                                     | D9.                   | MIPS Technologies; "Core Processor Interface Specification;" [Document No. MD00068]; <i>MIPS Technologies, Inc.</i> ; Rev. 1.11; March 30, 2001; pp. 1-26.  |                |
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|--------------------|---|-----------------|---------|
| Examiner Signature |  | Date Considered | 1/31/06 |
|--------------------|---|-----------------|---------|

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

<sup>1</sup> Unique citation designation number.

<sup>2</sup> Applicant is to place a check mark here if English language Translation attached.